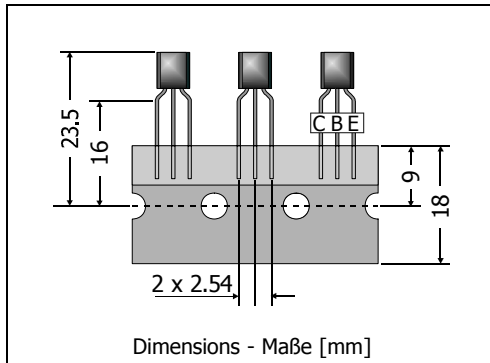


2N5550 / 2N5551**NPN**
General Purpose Si-Epitaxial Planar Transistors
Si-Epitaxial Planar-Transistoren für universellen Einsatz
NPN

Version 2006-06-17


 Power dissipation
 Verlustleistung

625 mW

 Plastic case
 Kunststoffgehäuse

 TO-92
 (10D3)

Weight approx. – Gewicht ca.

0.18 g

 Plastic material has UL classification 94V-0
 Gehäusematerial UL94V-0 klassifiziert

 Standard packaging taped in ammo pack
 Standard Lieferform gegurtet in Ammo-Pack
**Maximum ratings (T_A = 25°C)****Grenzwerte (T_A = 25°C)**

			2N5550	2N5551
Collector-Emitter-volt. – Kollektor-Emitter-Spannung	B open	V _{CEO}	140 V	160 V
Collector-Base-voltage – Kollektor-Basis-Spannung	E open	V _{CB0}	160 V	180 V
Emitter-Base-voltage – Emitter-Basis-Spannung	C open	V _{EBO}	6 V	
Power dissipation – Verlustleistung		P _{tot}	625 mW ¹⁾	
Collector current – Kollektorstrom (dc)		I _C	600 mA	
Junction temperature – Sperrschichttemperatur		T _j	-55...+150°C	
Storage temperature – Lagerungstemperatur		T _S	-55...+150°C	

Characteristics (T_j = 25°C)**Kennwerte (T_j = 25°C)**

			Min.	Typ.	Max.
DC current gain – Kollektor-Basis-Stromverhältnis ²⁾					
V _{CE} = 5 V, I _C = 1 mA	2N5550	h _{FE}	60	–	–
V _{CE} = 5 V, I _C = 10 mA		h _{FE}	60	–	250
V _{CE} = 5 V, I _C = 50 mA		h _{FE}	20	–	–
V _{CE} = 5 V, I _C = 1 mA	2N5551	h _{FE}	80	–	–
V _{CE} = 5 V, I _C = 10 mA		h _{FE}	80	–	250
V _{CE} = 5 V, I _C = 50 mA		h _{FE}	30	–	–
Collector-Emitter saturation voltage – Kollektor-Emitter-Sättigungsspg. ²⁾					
I _C = 10 mA, I _B = 1 mA	2N5550	V _{CEsat}	–	–	0.15 V
	2N5551	V _{CEsat}	–	–	0.15 V
I _C = 50 mA, I _B = 5 mA	2N5550	V _{CEsat}	–	–	0.25 V
	2N5551	V _{CEsat}	–	–	0.20 V

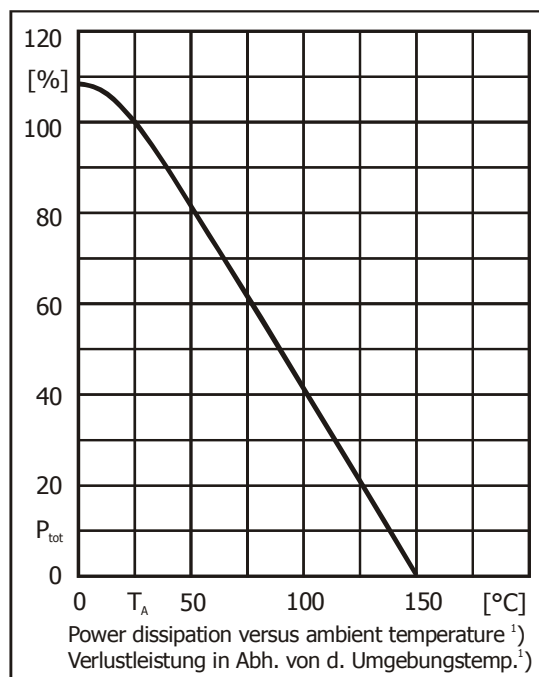
1 Valid, if leads are kept at ambient temperature at a distance of 2 mm from case

Gültig wenn die Anschlussdrähte in 2 mm Abstand vom Gehäuse auf Umgebungstemperatur gehalten werden

2 Tested with pulses t_p = 300 μs, duty cycle ≤ 2% – Gemessen mit Impulsen t_p = 300 μs, Schaltverhältnis ≤ 2%

Characteristics (T_j = 25°C)
Kennwerte (T_j = 25°C)

		Min.	Typ.	Max.	
Base-Emitter saturation voltage – Basis-Emitter-Sättigungsspannung ²⁾					
I _C = 10 mA, I _B = 1 mA	2N5550	V _{BEsat}	–	–	1.0 V
I _C = 50 mA, I _B = 5 mA		V _{BEsat}	–	–	1.2 V
I _C = 10 mA, I _B = 1 mA	2N5551	V _{BEsat}	–	–	1.0 V
I _C = 50 mA, I _B = 5 mA		V _{BEsat}	–	–	1.0 V
Collector-Base cutoff current – Kollektor-Base-Reststrom					
V _{CB} = 100 V, (E open)	2N5550	I _{CBO}	–	–	100 nA
V _{CB} = 120 V, (E open)	2N5551	I _{CBO}	–	–	50 nA
Emitter-Base cutoff current – Emitter-Basis-Reststrom					
V _{EB} = 4 V, (C open)		I _{EBO}	–	–	50 nA
Gain-Bandwidth Product – Transitfrequenz					
I _C = 10 mA, V _{CE} = 10 V, f = 100 MHz		f _T	100 MHz	–	300 MHz
Collector-Base Capacitance – Kollektor-Basis-Kapazität					
V _{CB} = 10 V, I _E = i _e = 0, f = 1 MHz		C _{CBO}	–	–	6 pF
Noise figure – Rauschzahl					
V _{CE} = 5 V, I _C = 200 μA, R _G = 2 kΩ,	2N5550	F	–	–	10 dB
f = 30 Hz ... 15 kHz	2N5551	F	–	–	8 dB
Thermal resistance junction to ambient air Wärmewiderstand Sperrschicht – umgebende Luft		R _{thA}	< 200 K/W ¹⁾		
Recommended complementary PNP transistors Empfohlene komplementäre PNP-Transistoren					2N5400 / 2N5401



¹ Valid, if leads are kept at ambient temperature at a distance of 2 mm from case
 Gültig wenn die Anschlussdrähte in 2 mm Abstand vom Gehäuse auf Umgebungstemperatur gehalten werden